Unit in mm

TOSHIBA Photocoupler GaAs Ired & Photo-Transistor

# **TLP504A,TLP504A-2**

Programmable Controllers AC / DC-Input Module Solid State Relay

The TOSHIBA TLP504A and TLP504A-2 consists of a photo-transistor optically coupled to a gallium arsenide infrared emitting diode.

The TLP504A offers two isolated channels in a eight lead plastic DIP package, while the TLP504A-2 provides four isolated channels in a sixteen plastic DIP package.

- Collector-emitter voltage: 55 V (min.)
- Current transfer ratio: 50% (min.)

Rank GB: 100% (min.)

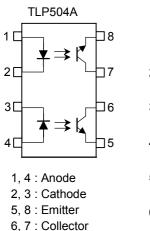
- Isolation voltage: 2500 Vrms (min.)
- UL recognized: UL1577,

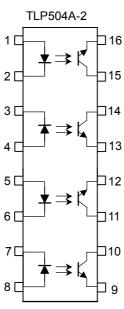
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# TLP504A 8 7 6 5 1.2 ± 0.15 0.5 ± 0.1 2.54 ± 0.25 TOSHIBA 11-10C4

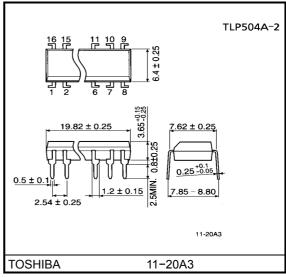
Weight: 0.54 g

### Pin Configurations (top view)





1, 4, 5, 8 : Anode 2, 3, 6, 7 : Cathode 9, 12, 13, 16 : Emitter 10, 11, 14, 15 : Collector



Weight: 1.1 g



### **Maximum Ratings (Ta = 25°C)**

Characteristic		Cymphol	Rat	Unit		
	Characteristic	Symbol	TLP504A	TLP504A-2	Unit	
	Forward current	lF	60	50	mA	
LED	Forward current derating	ΔI <sub>F</sub> / °C	–0.7 (Ta ≥ 39°C)	–0.5 (Ta ≥ 25°C)	mA /°C	
	Pulse forward current	I <sub>FP</sub>	1 (100µs pulse, 100pps)		Α	
	Reverse voltage	V <sub>R</sub>	5		V	
	Junction temperature	Tj	125		°C	
	Collector-emitter voltage	V <sub>CEO</sub>	5	55		
	Emitter-collector voltage	V <sub>ECO</sub>	7	7	V	
'n	Collector current	IC	50		mA	
Detector	Collector power dissipation (1 circuit)	PC	150	100	mW	
	Collector power dissipation derating (1 circuit Ta ≥ 25°C)	ΔP <sub>C</sub> / °C	-1.5	-1.0	mW /°C	
	Junction temperature	Tj	125		°C	
Sto	rage temperature range	T <sub>stg</sub>	-55~150		°C	
Оре	erating temperature range	T <sub>opr</sub>	-55~100		°C	
Lead soldering temperature		T <sub>sol</sub>	260 (10 s)		°C	
Total package power dissipation		R <sub>T</sub>	250	150	mW	
Total package power dissipation derating (Ta ≥ 25°C)		ΔP <sub>T</sub> / °C	-2.5	-1.5	mW / °C	
Isol	ation voltage	BVS	2500 (AC, 1min., R.H.≤ 60%) (Note 1)		Vrms	

(Note 1) Device considered a two terminal device: LED side pins shorted together and detector side pins shorted together.

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# **Recommended Operating Conditions**

Characteristics	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V <sub>CC</sub>	_	5	24	V
Forward current	lF	_	16	20	mA
Collector current	IC	_	1	10	mA
Operating temperature	T <sub>opr</sub>	-25	_	85	°C



# Individual Electrical Characteristics (Ta = 25°C)

	Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 10 mA	1.0	1.15	1.3	V
	Reverse current	I <sub>R</sub>	V <sub>R</sub> = 5 V	_	_	10	μΑ
	Capacitance	C <sub>T</sub>	V = 0, f = 1 MHz	_	30	_	pF
Detector	Collector–emitter breakdown voltage	V <sub>(BR)</sub> CEO	I <sub>C</sub> = 0.5 mA	55	-	1	٧
	Emitter-collector breakdown voltage	V <sub>(BR)</sub> ECO	I <sub>E</sub> = 0.1 mA	7	_	_	V
	Collector dorly ourrent	Collector dark current I <sub>CEO</sub>	V <sub>CE</sub> = 24 V		10	100	nA
	Conector dark current		V <sub>CE</sub> = 24 V, Ta = 85°C	_	2	50	μA
	Capacitance collector to emitter	C <sub>CE</sub>	V = 0, f = 1 MHz		10		pF

### **Coupled Electrical Characteristics (Ta = 25°C)**

Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Current transfer ratio	I <sub>C</sub> / I <sub>F</sub>	I <sub>F</sub> = 5 mA, V <sub>CE</sub> = 5 V Rank GB	50	-	600	- %
			100	1	600	
Saturated CTR	I <sub>C</sub> / I <sub>F (sat)</sub>	IF = 1 mA, V <sub>CE</sub> = 0.4 V Rank GB	_	60	_	. %
Saturated CTR			30	_	_	70
Collector-emitter saturation voltage	VCE (sat)	I <sub>C</sub> = 2.4 mA, I <sub>F</sub> = 8 mA	_	_	0.4	
		I <sub>C</sub> = 0.2 mA, I <sub>F</sub> = 1 mA Rank GB	_	0.2	_	V
			_	_	0.4	

# Isolation Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Capacitance input to output	$C_S$	V <sub>S</sub> = 0, f = 1 MHz	_	0.8	_	pF
Isolation resistance	R <sub>S</sub>	V <sub>S</sub> = 500 V	5×10 <sup>10</sup>	10 <sup>14</sup>	_	Ω
		AC, 1 minute	2500	_	_	Vrms
Isolation voltage	$BV_S$	AC, 1 second, in oil	_	5000	_	VIIIIS
		DC, 1 minute, in oil	_	5000	_	Vdc

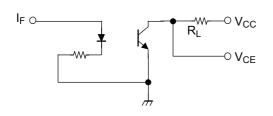
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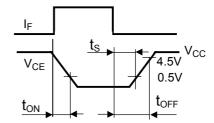


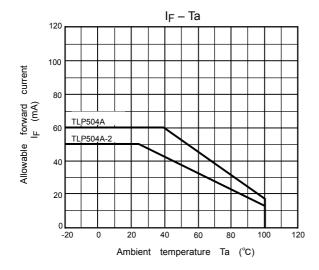
# **Switching Characteristics (Ta = 25°C)**

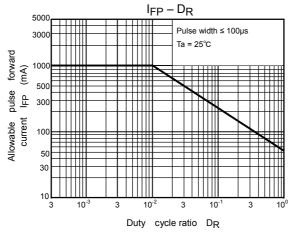
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Rise time	t <sub>r</sub>		_	2	_	
Fall time	t <sub>f</sub>	V <sub>CC</sub> = 10 V, I <sub>C</sub> = 2 mA	_	3	_	116
Turn-on time	t <sub>on</sub>	$R_L = 100\Omega$	_	3	_	μs
Turn-off time	t <sub>off</sub>		_	3	_	
Turn-on time	t <sub>ON</sub>		_	2	_	
Storage time	ts	$R_L = 1.9 \text{ k}\Omega$ (Fig.1) $V_{CC} = 5 \text{ V}, I_F = 16 \text{ mA}$	_	15	_	μs
Turn-off time	t <sub>OFF</sub>		_	25	_	

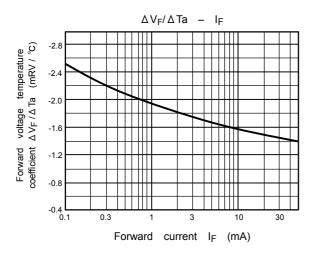
Fig. 1 Switching time test circuit

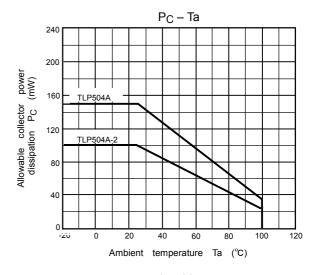


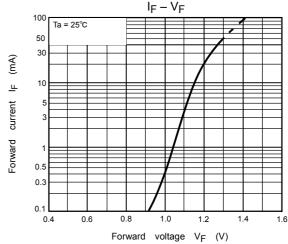


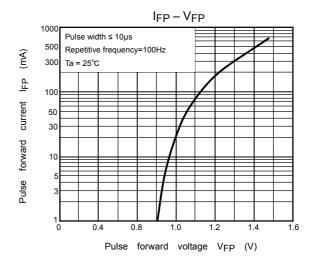


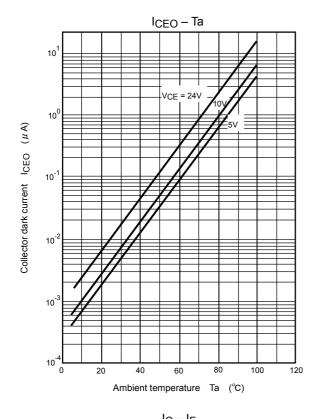


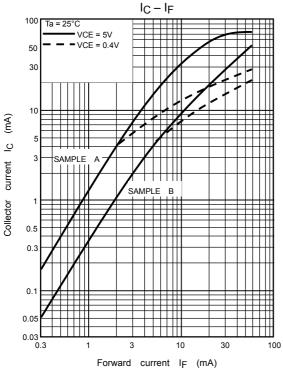


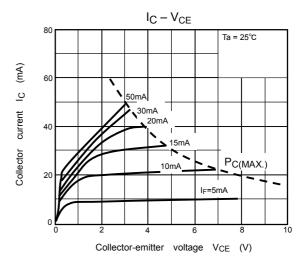


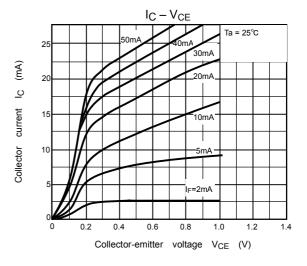


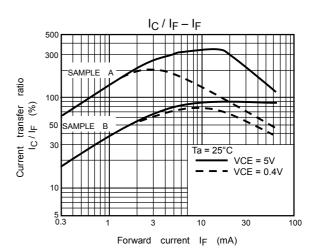


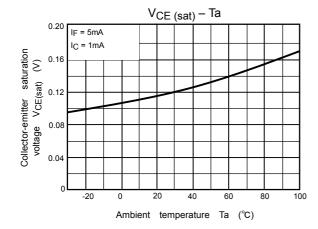


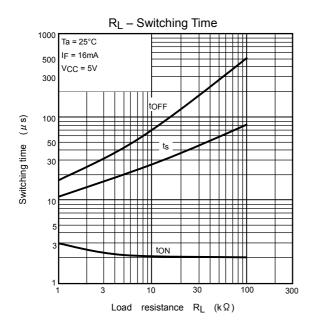


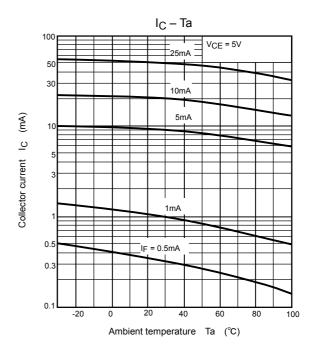












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